

Notice of References Cited	Application/Control No. 10/812,082	Applicant(s)/Patent Under Reexamination HUNG ET AL.	
	Examiner Ji H. Bae	Art Unit 2115	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,837,435	01-2005	Kehoe et al.	235/472.01
*	B	US-4,763,333	08-1988	Byrd, Kerry	714/22
*	C	US-6,760,850	07-2004	Atkinson et al.	713/320
*	D	US-2003/0145191	07-2003	Park, Jong-hyun	713/1
*	E	US-6,901,298	05-2005	Govindaraj et al.	700/21
*	F	US-6,032,255	02-2000	Shim et al.	713/2
*	G	US-6,336,161	01-2002	Watts, LaVaughn	711/103
*	H	US-5,765,001	06-1998	Clark et al.	713/340
*	I	US-5,557,777	09-1996	Culbert, Michael F.	713/2
*	J	US-7,028,220	04-2006	Park, Jeong Min	714/22
*	K	US-6,571,343	05-2003	Johnson et al.	713/340
*	L	US-6,996,733	02-2006	Hershenson et al.	713/340
*	M	US-6,990,603	01-2006	Strasser, Amnon A.	714/6

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.